19-2216; Rev 0; 10/01

MAXIM

Low-Jitter, Low-Noise LVPECL-to-LVDS Level Translator in an SC70 Package

General Description

The MAX9156 is an LVPECL-to-LVDS level translator that accepts a single LVPECL input and translates it to a single LVDS output. It is ideal for interfacing between LVPECL and LVDS interfaces in systems that require minimum jitter, noise, power, and space.

Ultra-low, $23ps_{p-p}$ added deterministic jitter and $0.6ps_{RMS}$ added random jitter ensure reliable communication in high-speed links that are highly sensitive to timing errors, especially those incorporating clock-and-data recovery, PLLs, serializers, or deserializers. The MAX9156's switching performance guarantees a 200Mbps data rate, but minimizes radiated noise by guaranteeing 0.5ns minimum output transition time.

The MAX9156 operates from a single +3.3V supply and consumes only 10mA supply current over a -40°C to +85°C temperature range. It is available in a tiny 6-pin SC70 package (half the size of a SOT23). Refer to the MAX9155 data sheet for a low-jitter, low-noise LVDS repeater in an SC70 package.

Features

- **Tiny SC70 Package**
- **Ultra-Low Jitter**
  $23ps_{p-p}$ Added Deterministic Jitter (2^{23}-1 PRBS)
  $0.6ps_{RMS}$ Added Random Jitter
- **0.5ns (min) Transition Time Minimizes Radiated Noise**
- **200Mbps Guaranteed Data Rate**
- **Low 10mA Supply Current**
- **Output Conforms to ANSI/EIA/TIA-644 LVDS Standard**
- **High-Impedance Inputs and Outputs in Power-Down Mode**

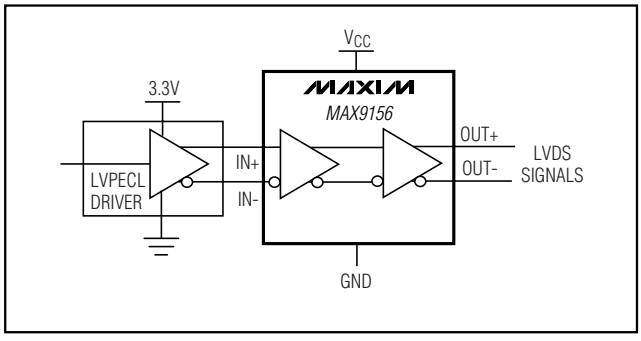
Applications

Digital Cross-Connects
Add/Drop Muxes
Network Switches/Routers
Cellular Phone Base Stations
DSLAMs
Multidrop Buses

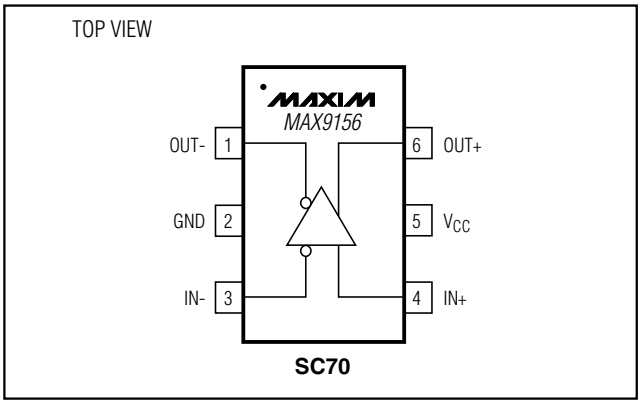
Ordering Information

PART	TEMP. RANGE	PIN-PACKAGE	TOP MARK
MAX9156EXT-T	-40°C to +85°C	6 SC70-6	ABD

Typical Operating Circuit



Pin Configuration



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ABSOLUTE MAXIMUM RATINGS

V_{CC} to GND .....-0.3V to +4.0V
IN+, IN- to GND .....-0.3V to +4.0V
OUT+, OUT- to GND .....-0.3V to +4.0V
Short-Circuit Duration (OUT+, OUT-) .....Continuous
Continuous Power Dissipation (T_A = +70°C)
6-Pin SC70 (derate 3.1mW/°C above +70°C) 245mW
Storage Temperature Range .....-65°C to +150°C
Junction Temperature .....+150°C
Operating Temperature Range .....-40°C to +85°C
ESD Protection
Human Body Model, IN+, IN-, OUT+, OUT- .....±8kV
Lead Temperature (soldering, 10s) .....+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

DC ELECTRICAL CHARACTERISTICS

(V_{CC} = +3.0V to +3.6V, R_L = 100Ω ±1%, $|V_{ID}|$ = 0.05V to V_{CC}, V_{CM} = $|V_{ID} / 2|$ to V_{CC} - $|V_{ID} / 2|$, T_A = -40°C to +85°C, unless otherwise noted. Typical values at V_{CC} = +3.3V, T_A = +25°C.) (Notes 1, 2)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
LVPECL INPUT							
Differential Input High Threshold	V_{TH}				7	50	mV
Differential Input Low Threshold	V_{TL}			-50	-7		mV
Input Resistor	R_{IN}	Figure 1		360	1328		kΩ
Input Current	I_{IN+}, I_{IN-}	IN+ = 3.6V, IN- = 0		-10	2.7	10	µA
		IN+ = 0, IN- = 3.6V		-10	2.7	10	
Power-Off Input Current	I_{IN+}, I_{IN-}	V_{CC} = 0, Figure 1	IN+ = 3.6V, IN- = 0	-10	2.7	10	µA
			IN+ = 0, IN- = 3.6V	-10	2.7	10	
LVDS OUTPUT							
Differential Output Voltage	V_{OD}	Figure 2		250	360	450	mV
Differential Output Voltage	ΔV_{OD}	Figure 2			0.008	25	mV
Offset (Common-Mode) Voltage	V_{OS}	Figure 2		1.125	1.25	1.375	V
Change in V_{OS} for Complementary Output States	ΔV_{OS}	Figure 2			0.005	25	mV
Output High Voltage	V_{OH}				1.44	1.6	V
Output Low Voltage	V_{OL}			0.9	1.08		V
Differential Output Voltage	V_{OD+}	IN+, IN- open		+250	+360	+450	mV
Power-Off Output Leakage Current	IO_{OFF}	V_{CC} = 0	OUT+ = 3.6V, other output open	-10	0.02	10	µA
			OUT- = 3.6V, other output open	-10	0.02	10	
Differential Output Resistance	RO_{DIFF}	V_{CC} = +3.6V or 0		100	260	400	Ω
Output Short Current	I_{SC}	V_{ID} = +50mV, OUT+ = GND			-5	-15	mA
		V_{ID} = -50mV, OUT- = GND			-5	-15	
POWER SUPPLY							
Supply Current	I_{CC}				10	15	mA

AC ELECTRICAL CHARACTERISTICS

(V_{CC} = +3.0V to +3.6V, R_L = 100Ω ±1%, C_L = 10pF, $|V_{ID}|$ = 0.15V to V_{CC}, V_{CM} = $|V_{ID} / 2|$ to V_{CC} - $|V_{ID} / 2|$, T_A = -40°C to +85°C, unless otherwise noted. Typical values at V_{CC} = +3.3V, T_A = +25°C.) (Notes 3, 4, 5) (Figures 3, 4)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Differential Propagation Delay High to Low	t_{PHLD}		1.3	2.0	2.8	ns
Differential Propagation Delay Low to High	t_{PLHD}		1.3	2.0	2.8	ns
Added Deterministic Jitter (Notes 6, 11)	t_{DJ}	200Mbps 2^{23}-1 PRBS data pattern		23	100	ps_{p-p}
Added Random Jitter (Notes 7, 11)	t_{RJ}	f_{IN} = 100MHz		0.6	2.9	ps_{RMS}
Differential Part-to-Part Skew (Note 8)	t_{SKPP1}			0.17	0.6	ns
Differential Part-to-Part Skew (Note 9)	t_{SKPP2}				1.5	ns
Switching Supply Current	I_{CCSW}			11.3	18	mA
Rise Time	t_{TLH}		0.5	0.66	1.0	ns
Fall Time	t_{THL}		0.5	0.64	1.0	ns
Input Frequency (Note 10)	f_{MAX}		100			MHz

Note 1: All devices are 100% tested at T_A = +25°C. Limits over temperature are guaranteed by design and characterization.

Note 2: Current into a pin is defined as positive. Current out of a pin is defined as negative. All voltages are referenced to ground except V_{TH}, V_{TL}, V_{OD}, and ΔV_{OD}.

Note 3: Guaranteed by design and characterization.

Note 4: Signal generator output (unless otherwise noted): frequency = 100MHz, 50% duty cycle, R_O = 50Ω, t_R = 1.5ns, and t_F = 1.5ns (0% to 100%).

Note 5: C_L includes scope probe and test jig capacitance.

Note 6: Signal generator output for t_{DJ}: V_{OD} = 150mV, V_{OS} = 1.2V, t_{DJ} includes pulse (duty cycle) skew.

Note 7: Signal generator output for t_{RJ}: V_{OD} = 150mV, V_{OS} = 1.2V.

Note 8: t_{SKPP1} is the magnitude difference of any differential propagation delays between devices operating over rated conditions at the same supply voltage, input common-mode voltage, and ambient temperature.

Note 9: t_{SKPP2} is the magnitude difference of any differential propagation delays between devices operating over rated conditions.

Note 10: Device meets V_{OD} DC specification and AC specifications while operating at f_{MAX}.

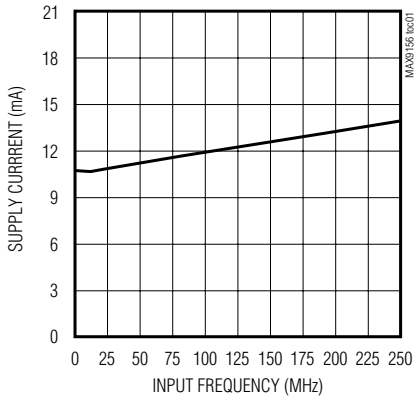
Note 11: Jitter added to the input signal.

Low-Jitter, Low-Noise LVPECL-to-LVDS Level Translator in an SC70 Package

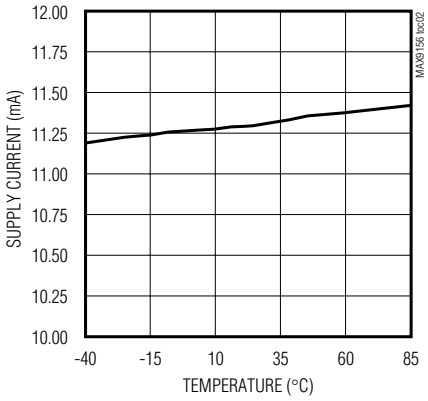
Typical Operating Characteristics

(V_{CC} = +3.3V, R_L = 100Ω ±1%, C_L = 10pF, $|V_{ID}|$ = 0.2V, V_{CM} = 1.2V, T_A = +25°C, unless otherwise noted. Signal generator output: frequency = 100MHz, 50% duty cycle, R_O = 50Ω, t_R = 1.5ns, and t_F = 1.5ns (0% to 100%), unless otherwise noted.)

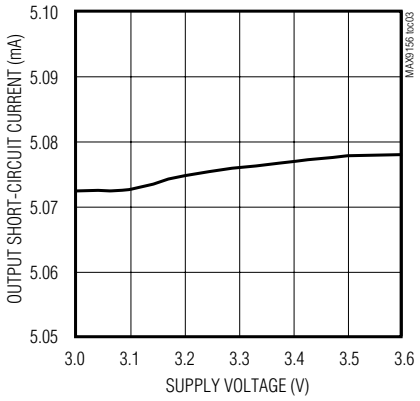
SUPPLY CURRENT vs. INPUT FREQUENCY



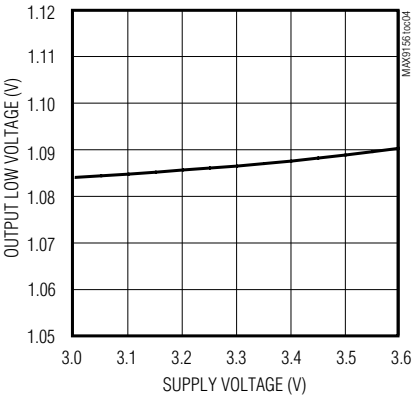
SWITCHING SUPPLY CURRENT vs. TEMPERATURE



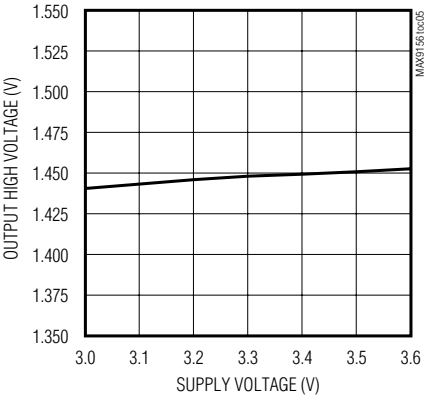
OUTPUT SHORT-CIRCUIT CURRENT vs. SUPPLY VOLTAGE



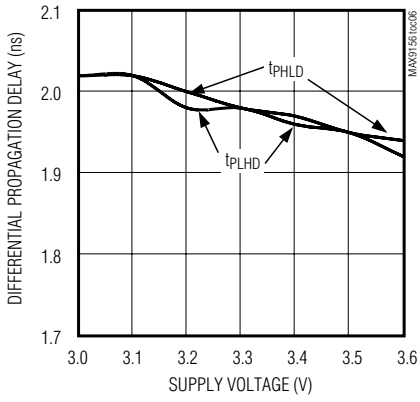
OUTPUT LOW VOLTAGE vs. SUPPLY VOLTAGE



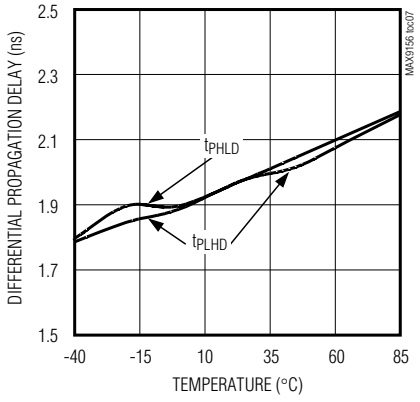
OUTPUT HIGH VOLTAGE vs. SUPPLY VOLTAGE



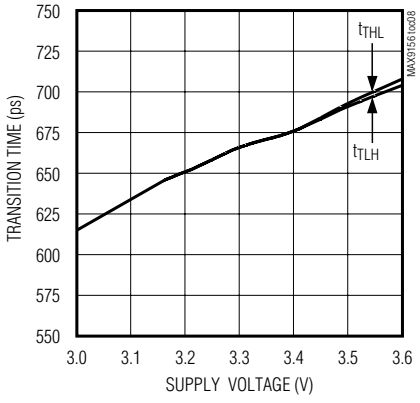
DIFFERENTIAL PROPAGATION DELAY vs. SUPPLY VOLTAGE



DIFFERENTIAL PROPAGATION DELAY vs. TEMPERATURE



TRANSITION TIME vs. SUPPLY VOLTAGE

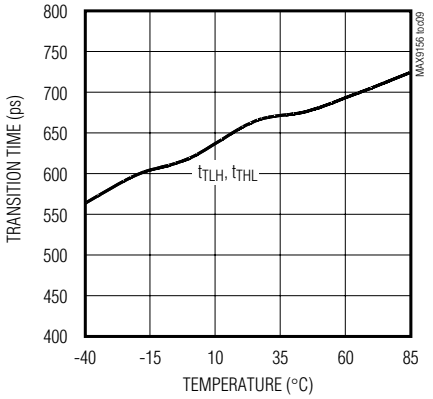


Low-Jitter, Low-Noise LVPECL-to-LVDS Level Translator in an SC70 Package

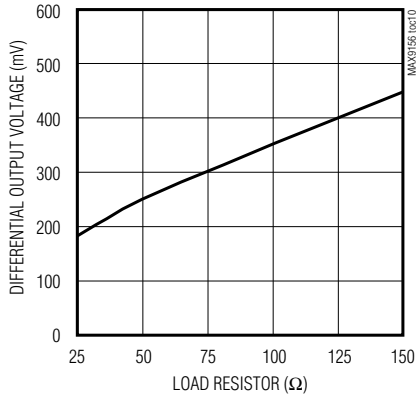
Typical Operating Characteristics (continued)

(V_{CC} = +3.3V, R_L = 100Ω ±1%, C_L = 10pF, $|V_{ID}|$ = 0.2V, V_{CM} = 1.2V, T_A = +25°C, unless otherwise noted. Signal generator output: frequency = 100MHz, 50% duty cycle, R_O = 50Ω, t_R = 1.5ns, and t_F = 1.5ns (0% to 100%), unless otherwise noted.)

TRANSITION TIME vs. TEMPERATURE



DIFFERENTIAL OUTPUT VOLTAGE vs. LOAD RESISTOR



Pin Description

PIN	NAME	FUNCTION
1	OUT-	Inverting LVDS Output
2	GND	Ground
3	IN-	Inverting LVPECL-Compatible Input
4	IN+	Noninverting LVPECL-Compatible Input
5	V_{CC}	Power Supply. Bypass V_{CC} to GND with a 0.01µF ceramic capacitor.
6	OUT+	Noninverting LVDS Output

Table 1. Function Table (Figure 2)

INPUT, V_{ID}	OUTPUT, V_{OD}
≥ 50mV	High
≤ -50mV	Low
50mV > V_{ID} > -50mV	Indeterminate
Open	High

Note: *V_{ID} = (IN+ - IN-), V_{OD} = (OUT+ - OUT-)*
High = 450mV ≥ V_{OD} ≥ 250mV
Low = -250mV ≥ V_{OD} ≥ -450mV

Detailed Description

The LVDS interface standard is a signaling method intended for point-to-point communication over a controlled-impedance medium, as defined by the ANSI/TIA/EIA-644 and IEEE 1596.3 standards. The LVDS standard uses a lower voltage swing than other common communication standards, achieving higher data rates with reduced power consumption while reducing EMI emissions and system susceptibility to noise.

The MAX9156 is a 200Mbps LVDS translator intended for high-speed, point-to-point, low-power applications. The MAX9156 accepts differential LVPECL inputs and produces an LVDS output. The input voltage range includes signals from GND up to V_{CC}, allowing interoperation with 3.3V LVPECL devices.

The MAX9156 provides a high output when the inputs are open. See Table 1.

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Applications Information

Supply Bypassing

Bypass V_{CC} with a high-frequency surface-mount ceramic 0.01µF capacitor as close to the device as possible.

Differential Traces

Input and output trace characteristics affect the performance of the MAX9156. Use controlled-impedance differential traces. Ensure that noise couples as common mode by running the traces within a differential pair close together.

Maintain the distance within a differential pair to avoid discontinuities in differential impedance. Avoid 90° turns and minimize the number of vias to further prevent impedance discontinuities.

Cables and Connectors

The LVDS standards define signal levels for interconnect with a differential characteristic impedance and termination of 100Ω. Interconnects with a characteristic impedance and termination of 90Ω to 132Ω impedance are allowed, but produce different signal levels (see *Termination*).

LVPECL signals are typically specified for 50Ω single-ended characteristic impedance interconnect terminated through 50Ω to V_{CC} - 2V.

Use cables and connectors that have matched differential impedance to minimize impedance discontinuities.

Termination

For point-to-point LVDS links, the termination resistor should be located at the LVDS receiver input and match the differential characteristic impedance of the transmission line.

Each line of a differential LVPECL link should be terminated through 50Ω to V_{CC} - 2V or be replaced by the Thevinin equivalent.

The LVDS output voltage level depends upon the differential characteristic impedance of the interconnect and the value of the termination resistance. The MAX9156 is guaranteed to produce LVDS output levels into 100Ω. With the typical 3.6mA output current, the MAX9156 produces an output voltage of 360mV when driving a 100Ω transmission line terminated with a 100Ω termination resistor (3.6mA × 100Ω = 360mV). For typical output levels with different loads, see the Differential Output Voltage vs. Load Resistor typical operating curve.

Chip Information

TRANSISTOR COUNT: 401

PROCESS: CMOS

Test Circuits and Timing Diagrams

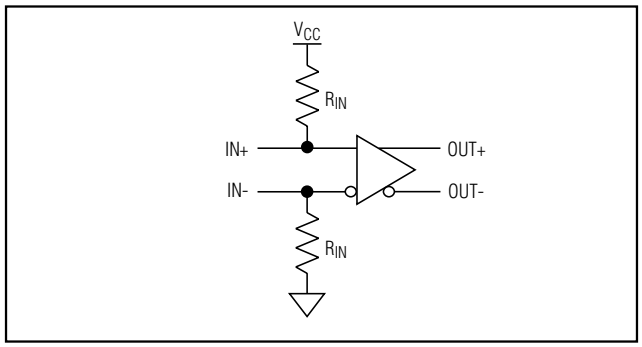


Figure 1. LVPECL Input Bias

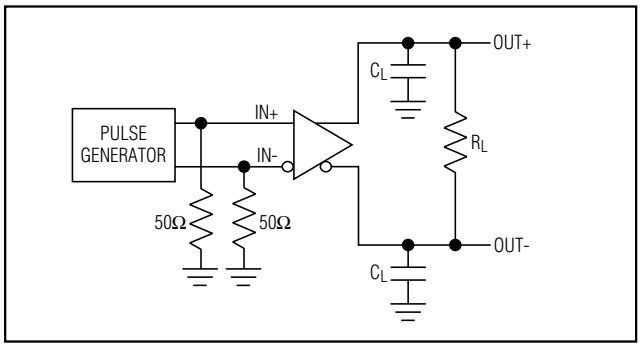


Figure 3. Transition Time and Propagation Delay Test Circuit

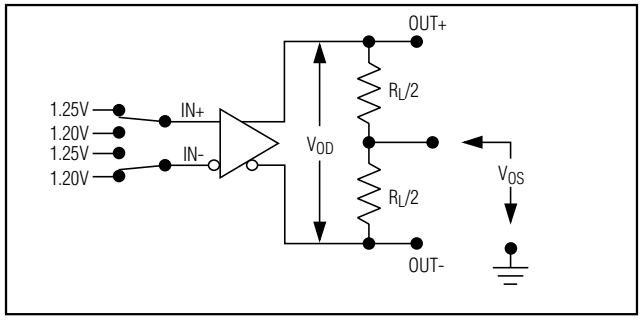


Figure 2. DC Load Test Circuit

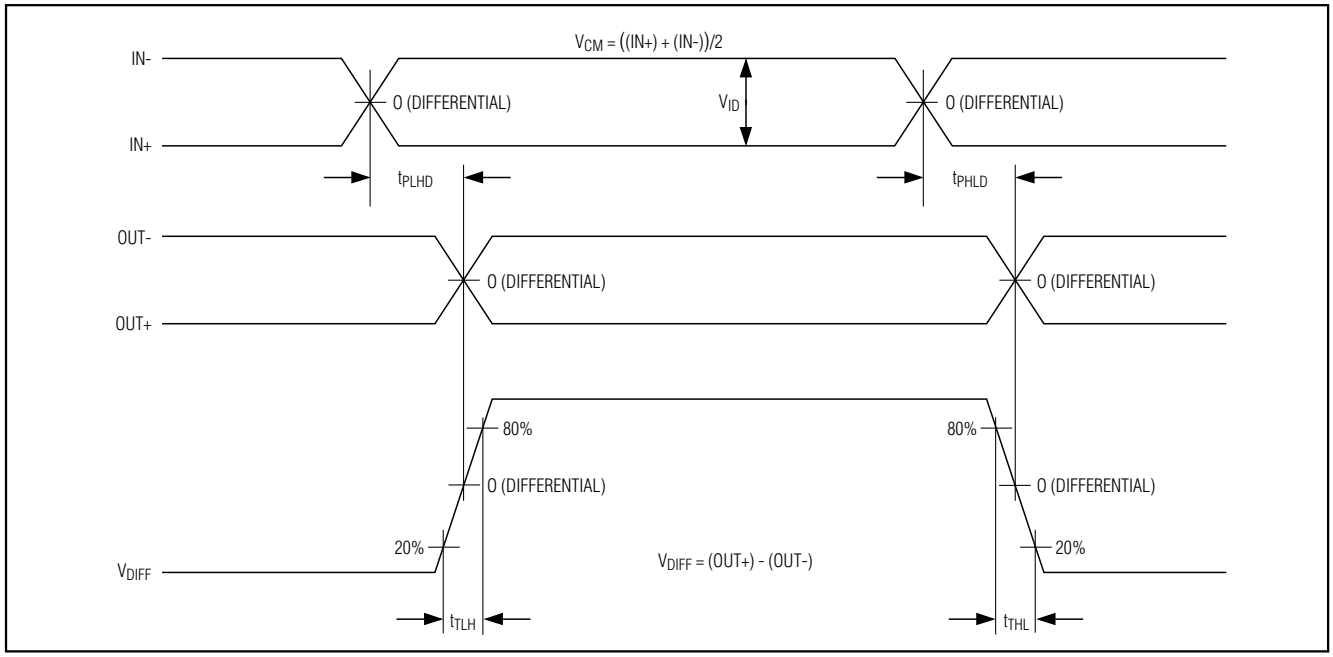
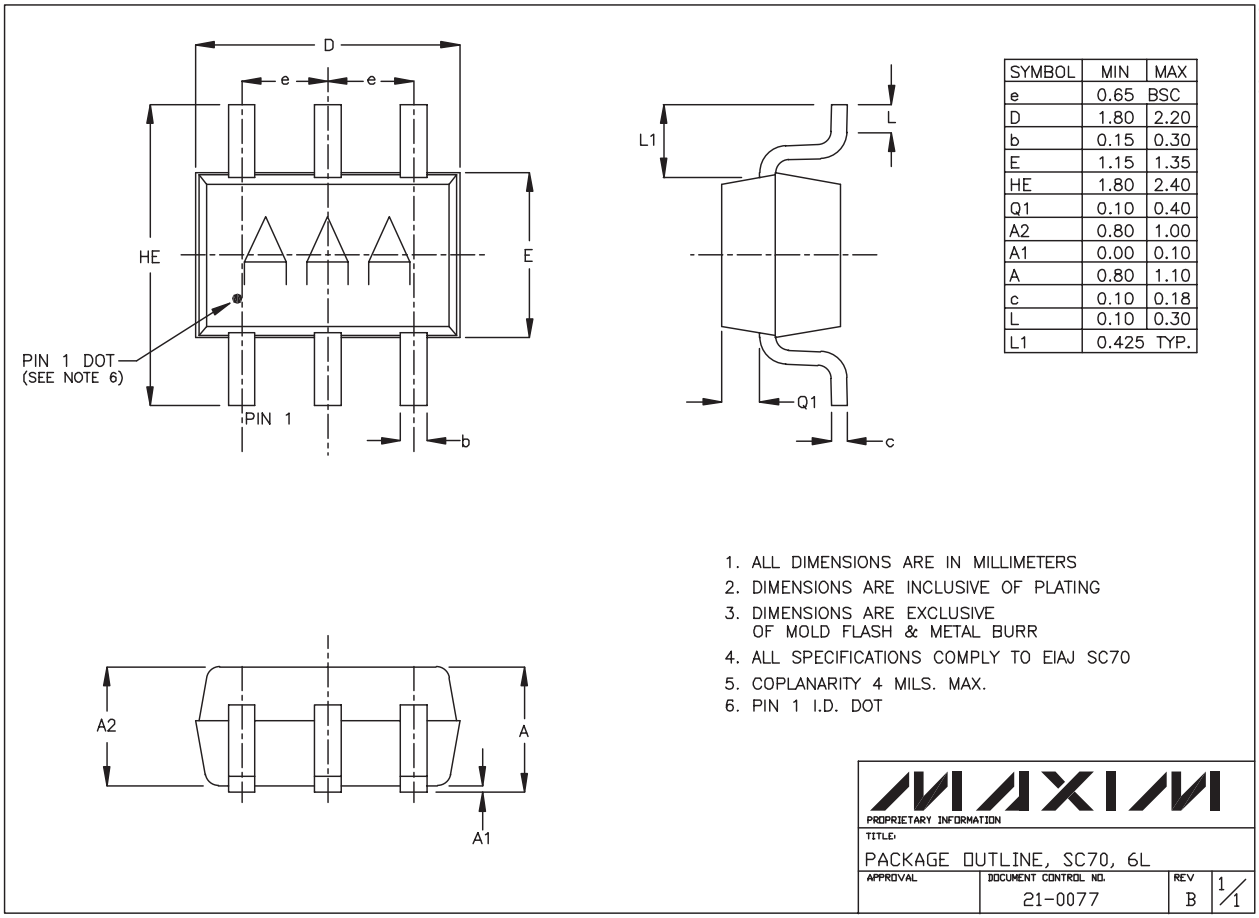


Figure 4. Transition Time and Propagation Delay Timing Diagram

Low-Jitter, Low-Noise LVPECL-to-LVDS Level Translator in an SC70 Package

Package Information



SYMBOL	MIN	MAX
e	0.65	BSC
D	1.80	2.20
b	0.15	0.30
E	1.15	1.35
HE	1.80	2.40
Q1	0.10	0.40
A2	0.80	1.00
A1	0.00	0.10
A	0.80	1.10
c	0.10	0.18
L	0.10	0.30
L1	0.425	TYP.